

Application/Control No.	Applicant(s)/Patent under Reexamination  CHEN ET AL.	
10/769,385		
Examiner	Art Unit	
Elena Tsoy	1762	

SEARCHED				
Class	Subclass	Oate	Examiner	
427	402, 419.1; 419.2, 419.8	2/2/2006	ET	
upd	aled	6/06 9/06	ET	
upla	eil	9/06	67	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST/EPO, JPO, Derwent	2/2/2008	ET	